

Application/Control No.	Applicant(s)/Patent under Reexamination
09/964,537	SHIN, YEONG JONG
Examiner	Art Unit

Soon D. Hyun

2661

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
370/331,335,336,342347; 455/436- 444,448 (text search only-see search history printout)	11/22/2005	НҮ	